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SHEET 1 OF 1

Form PTO 1448		U.S. DEPARTMEN	OF COMMERCE	ATTY DOCKET NO.		SERIAL N	10.	
(Modified)		PATENT AND TO	EMARK OFFICE	237688US0		10/617,	D48	
		_		APPLICANT				
LIST OF	REFER	RENCES CITED BY API	PLICANT	Terry V. LIEW, et al.				
			,	FILING DATE		GROUP		
				July 11, 2003		1711		
				U.S. PATENT DOCUMENTS		<u> </u>		
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· fr.	AA	2002/0051758 A1	05/02/2002	Heng CAI, et al.				
And	AB	6,051,216	04/18/2000	Morton L. BARR, et al.			,	
	AC	2002/0028223 A1	03/07/2002	Michael Lee VATTER, et al.				
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Form PTO 1449		U.S. DEPARTMENT	BE COMMERCE	ATTY DOCKET NO.		SERIAL	۷0.	
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LIST OF	REFEF	RENCES CITED BY API	PLICANT	Terry V. LIEW, et al.			•	
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EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FI IF A	LING DATE PPROPRIATE
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	AZ	11/11		·	Add	itional Refe	erences	sheet(s) attached
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Nov. 28, 2005

SHEET 1 OF 5

Form PTO 1	1449		U.S. DEPARTMENT		ATTY DOCKET NO.		SERIAL N	Ю.
(Modified)			PATENT AND TRAD	EMARK OFFICE	237688US0		10/617,	048
			·		APPLICANT			
LIST	OF I	REFE	RENCES CITED BY AP	PLICANT	Terry V. LIEW, et al.			
					FILING DATE		GROUP	
					July 11, 2003		1711	
					U.S. PATENT DOCUMENTS			
EXAMIN INITIA	L	_	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
×.	4	AA	2,823,195	02/11/58	Shorr, et al.			
		AB	3,723,566	03/27/73	Thompson, et al.			
		AC	4,322,400	03/30/82	E. Yuhas			
		AD	5,262,505	11/16/93	Nakashima, et al.			
		AE	5,407,986	04/18/95	Furukawa, et al.			
		AF	5,412,004	05/02/95	Tachibana, et al.			
		AG	5,473,041	12/05/95	M. Itoh			
		АН	5,567,428	10/22/96	K. Hughes			
		Al	5,725,882	03/10/98	Kuman, et al.			
		AJ	5,837,223	11/17/98	Barone, et al.			
		AK	5,874,069	02/23/99	Mendolia, et al.			
		AL	5,919,441	07/06/99	Mendolia, et al.			
5	/	АМ	5,981,680	11/09/99	Petroff, et al.			
N	$\Box$	AN	5,985,297	11/16/99	Mellul, et al.			
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			NUMBER	DATE	COUNTRY		YES	NO I
$\mathcal{L}$		AO	GB 134 8783	03/20/74	London		Х	
1		AP	EP 0 377 447 A2	07/11/90	EPO		Х	
		AQ	EP 0 693 517 A1	01/24/96	EPO		х	
			WO 97/36572	10/09/97	WIPO		Х	
			WO 97/36573	10/09/97	WIPO		X	
			FR 2 765 800	01/15/99	France (English Abstract Provided)	_		X
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A	$\leq$	AV	WO 99/06473	02/11/99	WIPO		Х	
/			OTHER RE	FERENCES (	Including Author, Title, Date, Pertinent	Pages, e	tc.)	
A		AW	Dow Corning® 2-81	78 Gellant, I	Ref. No. 27-1055-01, August 2002, 3	35 pp.		
1		AX	Dow Corning® 2-81	78 Gellant, I	Product Information Personal Care, 6	pp., 8/1	3/02	
		AY	Shin-Etsu Silicones i Powders for Persona	for Personal	Care, Product Brochure, KSP-100-10	01-102-10	03-104-10	5 "Hybrid Silicone
	,	, AZ	Shin-Etsu Siljcones	or Personal cone Powde	Care; Product Brochure, KSP- rs containing Fluoroalkyl or Phenyl	Addi	tional Refe	rences sheet(s) attached
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*Examine	er: Ini	tial If	eference is considered, of considered. Include co	whether or no ppy of this form	t citation is in conformance with MPEP 60 with next communication to applicant.	9; Draw li	ne through	citation if not in

Form PTO 1449		U.S. DEPARTMENT	OF COMMERCE	ATTY DOCKET NO.		SERIAL N	NO.
(Modified)		PATENT AND TRAC	EMARK OFFICE	237688US0		10/617,	048
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LIST OF	REFE	RENCES CITED BY AP	PLICANT	Terry V. LIEW, et al.			
				FILING DATE		GROUP	
				July 11, 2003		1711	
				U.S. PATENT DOCUMENTS			
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
1	AA	6,045,782	04/04/00	Krog, et al.	<u> </u>		
	AB	6,051,216	04/18/00	Barr, et al.			
	AC	6,060,072	05/09/00	Konik, et al.			
	AD	6,103,250	08/15/00	Brieva, et al.			
	AE	6,353,076 B1	03/05/02	Barr, et al.			
	AF	6,362,287	03/26/02	Chorvath, et al.			
	AG	6,362,288	03/26/02	Brewer, et al.			
	AH	6,423,324	07/23/02	Murphy, et al.			•
	Al	6,426,062	07/30/02	Chopra, et al.			(
	AJ	6,451,295 B1	09/17/02	Cai, et al.			
	AK	6,541,017	04/01/03	Lemann, et al.			
	AL	6,503,632 B1	01/07/03	Hayashi, et al.			
	AM	6,524,598	02/25/03	Sunkel, et al.			
AV	AN	6,569,955 B1	05/27/03	Brewer, et al.			
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1	•	NUMBER	DATE	COUNTRY		YES	
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/		EP 1 048 686	11/02/00	EPO		Х	
		EP 1 068 856	01/17/01	EPO (English Abstract Provided)			X
		WO 01/09239 A1	02/08/01	WIPO		Х	
		WO 01/97758 A2	<del> </del>	WIPO		X	
		WO 02/17870 A2	03/07/02	WIPO		х	
$\mid H / \mid$		WO 02/17871 A2	03/07/02	WIPO		X	
//	AV	WO 02/089760 A1	11/14/02	WIPO		X	
/ /		OTHER RE	FERENCES (	Including Author, Title, Date, Pertinent	Pages, e	tc.)	
1	AW	English Language Der	went Abstract	of EP 0 923 928, June 23, 1999			
//	AX	English Language Der	went Abstract	of EP 1 068 856, January 17, 2001			
1	AY	English Language Der	went Abstract	of FR 2 765 800, January 15, 1999			
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Form PTO 1449	,	U.S. DEPARTMENT	OF COMMERCE	ATTY DOCKET NO.		SERIAL I	NO.
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LIST OF	REFE	RENCES CITED BY AP	PLICANT	Terry V. LIEW, et al.		<del>,</del>	
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EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
$\mathcal{N}$	AA	2002/0048557 A1	04/25/02	Cai, et al.			
/'	AB	2003/0068348	04/10/03	Ferrari, et al.			
	AC	2003/0072730	04/17/03	Tournilhac			
	AD	2003/0082129 A1	05/01/03	Buckingham, et al.			
	AE	2003/0170188	09/11/03	Ferrari, et al.			
	AF	2003/0232030 A1	12/18/03	Lu, et al.			
	AG	2003/0235548 A1	12/25/03	Lu, et al.			
	АН	2003/0235552	12/25/03	Yu, W.			
	Al	2003/0235553 A1	12/25/03	Lu, et al.			
	AJ	2004/0001799 A1	01/01/04	Lu, et al.			
	AK	2004/0115153 A1	06/17/04	W. Yu			
	ÁL	2004/0115154 A1	06/17/04	W. Yu			
	АМ	2004/0120912 A1	06/24/04	W. Yu			
	AN	2004/0126336 A1	07/01/04	Hansenne, et al.			
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	AO	WO 03/013447 A2	02/20/03	WIPO		×	
	AP	WO 03/105788 A2	06/02/03	WIPO		х	
	AQ	EP 1 266 647	12/18/02	EPO (English Abstract Provided)			Х
	AR	EP 0 594 285 A2	04/27/94	EPO		×	
	AS	WO 2004/054523	07/01/04	WIPO	-	х	
	ΑT	WO 2004/054524	07/01/04	WIPO		х	
	AU	WO 01/97758 A2	12/27/01	WIPO		×	
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Form PTO 1449		U.S. DEPARTMENT		ATTY DOCKET NO.		SERIAL N	10.
(Modified)		PATENT AND TRAC	DEMARK OFFICE	237688US0		10/617,	048
				APPLICANT			
LIST OF	REFE	RENCES CITED BY AP	PLICANT	Terry V. LIEW, et al.			·
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EXAMINER		DOCUMENT	DATE	NAME	CLASS	SUB	FILING DATE
INITIAL	<del>, , , , , , , , , , , , , , , , , , , </del>	NUMBER	ļ		ODAGO	CLASS	IF APPROPRIATE
1/		2004/0170586 A1		Ferrari, et al.			
		2004/0180032 A1	09/16/04	Manelski, et al.	ļ		
	AC	2005/0020769 A1	01/27/05	Lu, et al.	ļ		
		2005/0009989 A1		Liew, et al.			
<b>  </b>		2005/0089492 A1	04/28/05	Lu, et al.			
<b> </b>		6,916,464 B2		Hansenne, et al.	ļ		
<b></b>	AG	2005/0158260 A1	07/21/05	Ferrari, et al.			
		5,969,172	10/19/99	Susan A. Nye			
<b> </b>	Al	2002/0051758	05/02/02	Cai, et al.			
	AJ	4,822,852	04/18/89	Wittmann, et al.			
	AK	2,823,218	02/11/58	Speier, et al.			
	AL	2003/0228333	12/11/03	Fecht, et al.			
4	AM	2004/0197285	10/07/04	Heidi Marie Van Dort			
	AN	2004/0223936 A1	11/11/04	Fecht, et al.			
77			FO	REIGN PATENT DOCUMENTS	*	·	•
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Form PTO 1449		U.S. DEPARTMENT ( PATENT AND TRAD	OF COMMERCE	ATTY DOCKET NO.		SERIAL N	١0.	
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LIST OF	REFEI	RENCES CITED BY API	PLICANT	Terry V. LIEW, et al.				
				FILING DATE		GROUP		
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				U.S. PATENT DOCUMENTS				
EXAMINER		DOCUMENT	DATE	NAME	CLASS	SUB		LING DATE
INITIAL		NUMBER			CLASS	CLASS	IF A	PPROPRIATE
1/1/		·		Michael Lee Vatter, et al.	ļ			
-//		6,376,078	04/23/02	Yoshinori Inokuchi	ļ			
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Form PTO 1449 (Modified)		U.S. DEPARTMENS PATENT AND TRAD	FOOTH SEC	ATTY DOCKET NO.		SERIAL N	0.
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LIST OF	REFE	RENCES CITED BY APP	PLICANT	Michell CHEN, et al.			
			•	FILING DATE		GROUP	
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				U.S. PATENT DOCUMENTS		_	
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
X	*	2,823,195	02/11/58	Shorr, et al.			
	AB	3,723,566	03/27/73	Thompson, et al.			
	AC	4,322,400	03/30/82	E. Yuhas			
	AD	5,262,505	11/16/93	Nakashima, et al.			,
	<b>∖</b> AE	5,407,986	04/18/95	Furukawa, et al.			
	A	5,412,004	05/02/95	Tachibana, et al.			
	AG	5,473,041	12/05/95	M. Itoh			
	AH	5,67,428	10/22/96	K. Hughes			
	Al	5,726,882	03/10/98	Kuman, et al.			
	AJ	5,837,223	11/17/98	Barone, et al.	1		-
	AK	5,874,069	02/23/99	Mendolia, et al.			
	AL	5,919,441	07/06/99	Mendolia, et al.			
		5,981,680		Petroff, eval.			:
-	AN	5,985,297	11/16/99	Mellul et al.			
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		DOCUMENT NUMBER	DATE	COUNTRY		ľ	TRANSLATION
	AO	GB 134 8783	03/20/74	London		YES X	NO
		EP 0 377 447 A2		EPO		- ^	
		EP 0 693 517 A1	<u> </u>	PRO PRO		×	
		WO 97/36572	<b>/</b>	WIRO		×	
		WO 97/36573	10/09/97	WIPA		×	
				France (English Abstract Provided)		<del></del>	<del></del>
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		WO 99/06473	02/11/99	WIPO		<del></del>	X
		<del>' /                                   </del>		<u> </u>		<u> </u>	
				Including Author, Title, Date, Pertinent		tc.)	
	AW	Doy Corning® 2-81	78 Gellant, R	Ref. No. 27-1055-01, August 2002, 3	35 pp.		
	4	Dow Corning® 2-81	78 Gellant, P	roduct Information Personal Care, 6	pp., 8/13	3/02	
	AY	Shin-Etsu Silicones f Powders for Personal	or Personal ( Care" 2000	Care; Product Brochure, KSP-100	01-102-10	3.104.105	"Hybrid Silicone
	AZ	Shin-Etsu Silicones	or Personal (	Care; Product Brochure, KSP- rs containing Fluoroalkyl or Phenyl		ional Pefor	ences sheet(s) attached
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Form PTO 1449		U.S. DEPARTMENT PATENT AND TRA	OF COMMERCE	ATTY DOCKET NO.		SERIAL	
(Modified)		PATENT AND TRA	ENIAN OFFICE	275576US0		11/193	444 10/6/1,
				APPLICANT			
LIST OF	REFE	RENCES CITED BY AP	PLICANT	Michell CHEN, et al.			
				FILING DATE		GROUP	
				August 1, 2005		1615	
				U.S. PATENT DOCUMENTS			
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE
	A	6,045,782	04/04/00	Krog, et al.	Ī		
	AB	6,051,216	04/18/00	Barr, et al.	<u> </u>		
	AC	6,060,072	05/09/00	Konik, et al.			
	AD	6,103,250	08/15/00	Brieva, et al.	<u> </u>		
	AE	6,353,076 BL	03/05/02	Barr, et al.			
	AF	6,362,287	03/26/02	Chorvath, et al.	1	/	
	AG	6,362,288	03/26/02	Brewer, et al.			
	AH	6,423,324	07/23/02	Murphy, et al.			
	Al	6,426,062	07/30/02	Chopra, et al.	1		
	AJ	6,451,295 B1	09/17/08	Cai, et al.			
	AK	6,541,017	04/01/03	Lemann, et al.	1		
	AL	6,503,632 B1	01/07/03	Hayashi, et al.			
<u> </u>	АМ	6,524,598	02/25/03	Sunkel, et al.	1		
	AN	6,569,955 B1	05/27/03	Brewer, et al.			
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